



COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET

Product Summary

Device	V _{(BR)DSS}	$R_{DS(on) max}$ I_D $T_A = +25$	
Q2	40V	24mΩ @ V _{GS} = 10V	6.9A
QZ	400	$32m\Omega$ @ $V_{GS} = 4.5V$	6.0A
Q1	-40V	45mΩ @ V _{GS} = -10V	-5.1A
		55 m Ω @ V _{GS} = -4.5V	-4.5A

Description

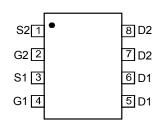
This new generation MOSFET has been designed to minimize the onstate resistance ($R_{DS(ON)}$) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- DC-DC Converters
- · Power Management Functions
- Backlighting



Top View



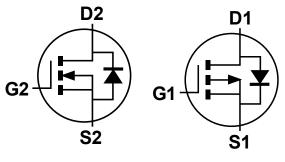
TOP VIEW Internal Schematic

Features and Benefits

- Low Input Capacitance
- Low On-Resistance
- · Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish Matte Tin annealed over Copper leadframe Solderable per MIL-STD-202, Method 208 (3)
- Weight: 0.074 grams (approximate)



N-Channel MOSFET

P-Channel MOSFET

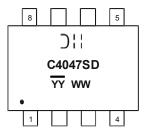
Ordering Information (Note 4)

The state of the s		
Part Number	Case	Packaging
DMC4047LSD-13	SO-8	2.500/Tape & Reel

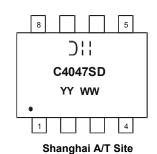
Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information



Chengdu A/T Site



YYWW_= Date Code Marking YY or YY = Year (ex: 13 = 2013) WW = Week (01 - 53) YY = Date Code Marking for SA

⊃¦¦ = Manufacturer's Marking

C4047SD = Product Type Marking Code

WW = Week (01 - 53)

YY = Date Code Marking for SAT (Shanghai Assembly/ Test site)
YY = Date Code Marking for CAT (Chengdu Assembly/ Test site)



Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value_Q2	Value_Q1	Units		
Drain-Source Voltage	V_{DSS}	40	-40	V		
Gate-Source Voltage	V _{GSS}	±20	±20	V		
Continuous Drain Current (Note 6) V _{GS} = 10V	Steady State	T _A = +25°C T _A = +70°C	I _D	7.0 5.6	-5.1 -4.1	Α
Continuous Diam Current (Note 6) VGS - 10V	t<10s	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I _D	9.0 7.2	-6.5 -5.2	Α
Maximum Body Diode Forward Current (Note 6)	I _S	2.5	-2.5	Α		
Pulsed Drain Current (10µs pulse, duty cycle = 19	I _{DM}	70	-40	Α		
Avalanche Current (Notes 7) L = 0.1mH	I _{AR}	20	20	А		
Repetitive Avalanche Energy (Notes 7) L = 0.1m	E _{AR}	20	20	mJ		

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units	
Total Power Dissipation (Note 5)	T _A = +25°C	D.	1.3	W
Total Power Dissipation (Note 5)	T _A = +70°C	P_{D}	0.8	
Thermal Pegistenes - Junction to Ambient (Note 5)	Steady state	В	98	°C/W
Thermal Resistance, Junction to Ambient (Note 5)	t<10s	$R_{ hetaJA}$	59	
Total Power Dissipation (Note 6)	T _A = +25°C	Б	1.8	W
Total Fower Dissipation (Note 6)	T _A = +70°C	P_{D}	1.1	
Thermal Pegistance Junction to Ambient (Note 6)	Steady state	D	71	°C/W
Thermal Resistance, Junction to Ambient (Note 6)	t<10s	$R_{\theta JA}$	43	
Thermal Resistance, Junction to Case (Note 6)	$R_{ heta JC}$	11.8		
Operating and Storage Temperature Range		T _{J,} T _{STG}	-55 to +150	°C

Electrical Characteristics N-Channel Q2 (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)						
Drain-Source Breakdown Voltage	BV _{DSS}	40	_	_	V	$V_{GS} = 0V$, $I_D = 250 \mu A$
Zero Gate Voltage Drain Current	I _{DSS}	_	_	1	μA	V _{DS} = 40V, V _{GS} = 0V
Gate-Source Leakage	I _{GSS}	_	_	±100	nA	V _{GS} = ±20V, V _{DS} = 0V
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	V _{GS(th)}	1.4	_	2.4	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
Static Drain-Source On-Resistance	D	_	15	24	mΩ	V _{GS} = 10V, I _D = 6A
Static Dialii-Source Off-Resistance	R _{DS(ON)}	_	20	32	11122	$V_{GS} = 4.5V, I_D = 5A$
Diode Forward Voltage	V_{SD}	_	0.7	1.0	V	$V_{GS} = 0V, I_S = 1.0A$
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	C _{iss}	_	1060	_		\\ - 20\\ \\ - 0\\
Output Capacitance	Coss	_	84	_	pF	$V_{DS} = 20V, V_{GS} = 0V,$ f = 1.0MHz
Reverse Transfer Capacitance	C _{rss}	_	58	_		
Gate Resistance	R_G	_	1.6	_	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$
Total Gate Charge (V _{GS} = 4.5V)	Qg	_	8.8	_		
Total Gate Charge (V _{GS} = 10V)	Q_g	_	19.1	_	nC	V _{DS} = 20V. I _D = 8A
Gate-Source Charge	Q_{gs}	_	3.0	_	110	V _{DS} - 20V, I _D - 8A
Gate-Drain Charge	Q_{gd}	_	2.5	_		
Turn-On Delay Time	t _{D(on)}	_	5.3	_		$V_{DD} = 25V, R_L = 2.5\Omega$
Turn-On Rise Time	t _r	_	7.1	_	nS	
Turn-Off Delay Time	t _{D(off)}	_	15.1	_	113	V_{GS} = 10V, R_G = 3 Ω
Turn-Off Fall Time	t _f	_	4.8	_		
Body Diode Reverse Recovery Time	t _{rr}	_	10.5	_	nS	I _F = 8A, di/dt = 100A/μs
Body Diode Reverse Recovery Charge	Q _{rr}	_	4.15	_	nC	I _F = 8A, di/dt = 100A/μs



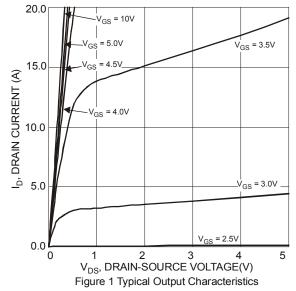
Electrical Characteristics P-Channel Q1 (@T_A = +25°C, unless otherwise specified.)

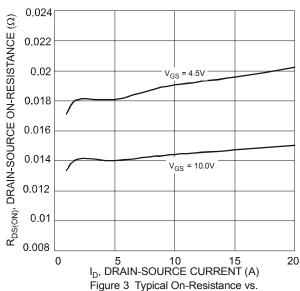
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition		
OFF CHARACTERISTICS (Note 8)								
Drain-Source Breakdown Voltage	BV _{DSS}	-40		_	V	$V_{GS} = 0V, I_D = -250\mu A$		
Zero Gate Voltage Drain Current	I _{DSS}			-1	μΑ	V _{DS} = -40V, V _{GS} = 0V		
Gate-Source Leakage	I _{GSS}	_		±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$		
ON CHARACTERISTICS (Note 8)								
Gate Threshold Voltage	V _{GS(th)}	-1.0		-2.2	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$		
Static Desir Course On Besistance	_	_	33	45	0	V _{GS} = -10V, I _D = -5A		
Static Drain-Source On-Resistance	R _{DS(ON)}	_	40	55	mΩ	$V_{GS} = -4.5V, I_D = -4A$		
Diode Forward Voltage	V_{SD}	_	-0.7	-1.0	V	V _{GS} = 0V, I _S = -1.0A		
DYNAMIC CHARACTERISTICS (Note 9)								
Input Capacitance	C _{iss}	_	1154	_		V _{DS} = -20V, V _{GS} = 0V f = 1.0MHz		
Output Capacitance	Coss	_	84		pF			
Reverse Transfer Capacitance	Crss	_	66	_				
Gate Resistance	R_{G}		12.6	_	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$		
Total Gate Charge (V _{GS} = -4.5V)	Q_g		10.6	_		V 00V I- 40A		
Total Gate Charge (V _{GS} = -10V)	Q_g	_	21.5		nC			
Gate-Source Charge	Q_{gs}		2.2	_	IIC	V _{DS} = -20V, I _D = -4.9A		
Gate-Drain Charge	Q_{gd}		3.3	_				
Turn-On Delay Time	t _{D(on)}	_	8.7	_		V _{DS} = -20V, I _D = -3.9A V _{GS} = -4.5V, R _G = 1Ω		
Turn-On Rise Time	t _r	_	19.6	_	-0			
Turn-Off Delay Time	t _{D(off)}	_	34.9	_	nS			
Turn-Off Fall Time	t _f	_	25.5	_				
Body Diode Reverse Recovery Time	t _{rr}	_	9.61		nS	$I_S = -3.9A$, $dI/dt = 100A/\mu s$		
Body Diode Reverse Recovery Charge	Q_{rr}		3.30	_	nC	$I_S = -3.9A$, $dI/dt = 100A/\mu s$		

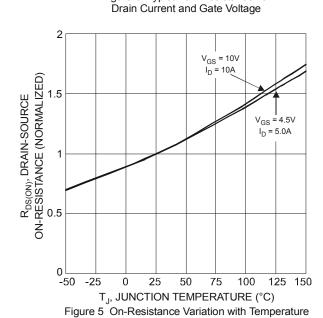
- 5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
 6. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
 7. IAR and EAR rating are based on low frequency and duty cycles to keep TJ = +25°C
 8. Short duration pulse test used to minimize self-heating effect.
 9. Guaranteed by design. Not subject to product testing.

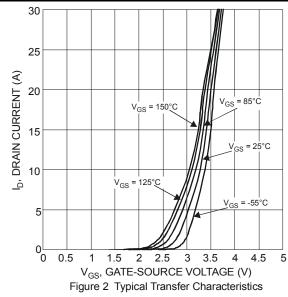


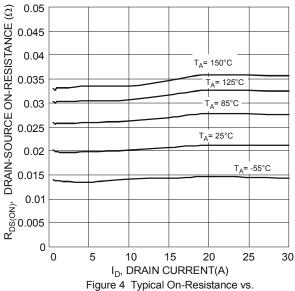
N-Channel Q2

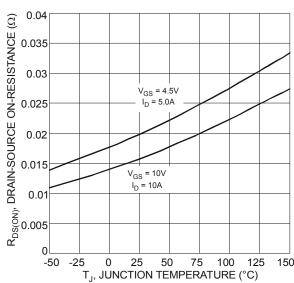












Drain Current and Temperature



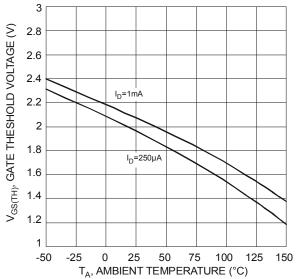
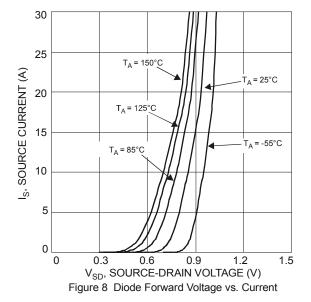
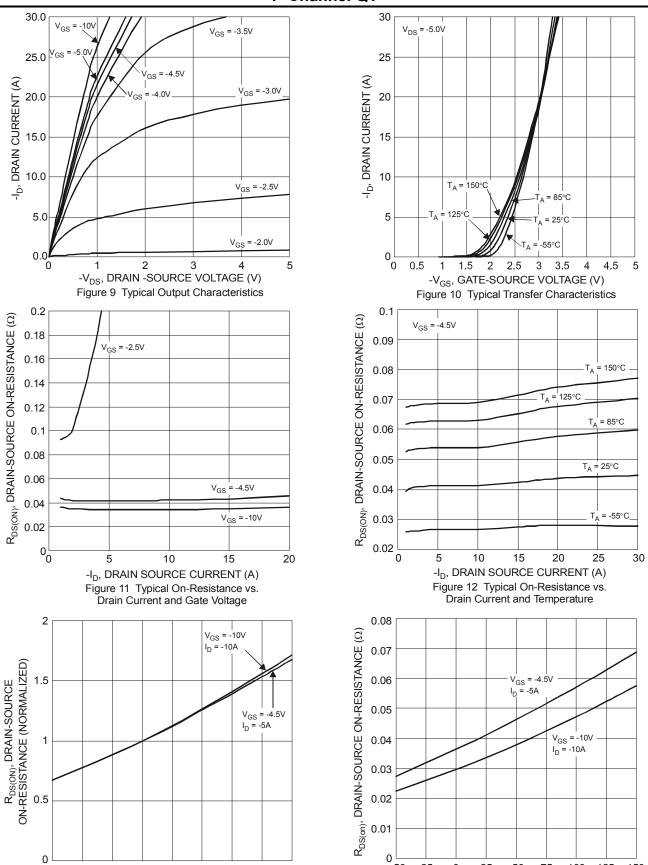


Figure 7 Gate Theshold Variation vs Ambient Temperature





P-Channel Q1



-50

25

50

T_J, JUNCTION TEMPERATURE (°C)

Figure 13 On-Resistance Variation with Temperature

75

100

-50

125

5 0 25 50 75 100 12 ${
m T_J}$, JUNCTION TEMPERATURE (°C)

Figure 14 On-Resistance Variation with Temperature



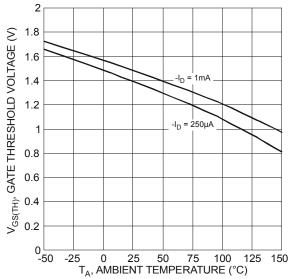
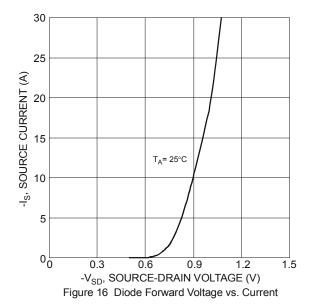


Figure 15 Gate Threshold Variation vs. Ambient Temperature

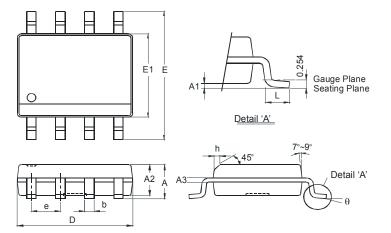


r(t), TRANSIENT THERMAL RESISTANCE D = 0.1 D = 0.05 D = 0.020.01 D = 0.01 D = 0.005 $R_{\theta JA}(t) = r(t) * R_{\theta JA}$ $R_{\theta JA} = 94^{\circ}C/W$ Duty Cycle, D = t1/t2 Single Pulse 0.01 0.1 1 t1, PULSE DURATION TIMES (sec) Figure 17 Transient Thermal Resistance 0.00001 0.0001 0.001 100 1,000



Package Outline Dimensions

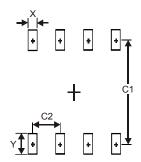
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



SO-8					
Dim	Min	Max			
Α	1	1.75			
A 1	0.10	0.20			
A2	1.30	1.50			
A3	0.15	0.25			
b	0.3	0.5			
D	4.85	4.95			
Е	5.90	6.10			
E1	3.85	3.95			
е	1.27	Тур			
h	-	0.35			
Ĺ	0.62	0.82			
θ	0°	8°			
All Dimensions in mm					

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)			
X	0.60			
Y	1.55			
C1	5.4			
C2	1.27			



IMPORTANT NOTICE

DIODES INCORPORATED MAKES NO WARRANTY OF ANY KIND, EXPRESS OR IMPLIED, WITH REGARDS TO THIS DOCUMENT, INCLUDING, BUT NOT LIMITED TO, THE IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION).

Diodes Incorporated and its subsidiaries reserve the right to make modifications, enhancements, improvements, corrections or other changes without further notice to this document and any product described herein. Diodes Incorporated does not assume any liability arising out of the application or use of this document or any product described herein; neither does Diodes Incorporated convey any license under its patent or trademark rights, nor the rights of others. Any Customer or user of this document or products described herein in such applications shall assume all risks of such use and will agree to hold Diodes Incorporated and all the companies whose products are represented on Diodes Incorporated website, harmless against all damages.

Diodes Incorporated does not warrant or accept any liability whatsoever in respect of any products purchased through unauthorized sales channel. Should Customers purchase or use Diodes Incorporated products for any unintended or unauthorized application, Customers shall indemnify and hold Diodes Incorporated and its representatives harmless against all claims, damages, expenses, and attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized application.

Products described herein may be covered by one or more United States, international or foreign patents pending. Product names and markings noted herein may also be covered by one or more United States, international or foreign trademarks.

This document is written in English but may be translated into multiple languages for reference. Only the English version of this document is the final and determinative format released by Diodes Incorporated.

LIFE SUPPORT

Diodes Incorporated products are specifically not authorized for use as critical components in life support devices or systems without the express written approval of the Chief Executive Officer of Diodes Incorporated. As used herein:

- A. Life support devices or systems are devices or systems which:
 - 1. are intended to implant into the body, or
 - 2. support or sustain life and whose failure to perform when properly used in accordance with instructions for use provided in the labeling can be reasonably expected to result in significant injury to the user.
- B. A critical component is any component in a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or to affect its safety or effectiveness.

Customers represent that they have all necessary expertise in the safety and regulatory ramifications of their life support devices or systems, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of Diodes Incorporated products in such safety-critical, life support devices or systems, notwithstanding any devices- or systems-related information or support that may be provided by Diodes Incorporated. Further, Customers must fully indemnify Diodes Incorporated and its representatives against any damages arising out of the use of Diodes Incorporated products in such safety-critical, life support devices or systems.

Copyright © 2013, Diodes Incorporated

www.diodes.com